SHEET 1 OF 1

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EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME		CLASS	SUBCLASS	FILING DATE	
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V	JP 9-231110	09/05/1997	Japan (Full & English A	Japanese Text bstract)			X	
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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